



HY5V56B(L/S)F-I Series

4 Banks x 4M x 16bits Synchronous DRAM

Preliminary

DESCRIPTION

The HY5V56B(L)F is a 268,435,456bit CMOS Synchronous DRAM, ideally suited for the Mobile applications which require low power consumption and industrial temperature range. HY5V56B(L)F is organized as 4banks of 4,194,304x16

HY5V56B(L)F is offering fully synchronous operation referenced to a positive edge of the clock. All inputs and outputs are synchronized with the rising edge of the clock input. The data paths are internally pipelined to achieve very high bandwidth. All input and output voltage levels are compatible with LVTTL.

Programmable options include the length of pipeline (Read latency of 2 or 3), the number of consecutive read or write cycles initiated by a single control command (Burst length of 1,2,4,8, or full page), and the burst count sequence(sequential or interleave). A burst of read or write cycles in progress can be terminated by a burst terminate command or can be interrupted and replaced by a new burst read or write command on any cycle. (This pipelined design is not restricted by a '2N' rule.)

FEATURES

- Single 3.3±0.3V power supply
- All device balls are compatible with LVTTL interface
- 54Ball FBGA (13.5mm x 8.0mm)
- All inputs and outputs referenced to positive edge of system clock
- Data mask function by UDQM or LDQM
- Internal four banks operation
- Auto refresh and self refresh
- 8192 refresh cycles / 64ms
- Programmable Burst Length and Burst Type
 - 1, 2, 4, 8 or Full page for Sequential Burst
 - 1, 2, 4 or 8 for Interleave Burst
- Programmable $\overline{\text{CAS}}$ Latency ; 2, 3 Clocks

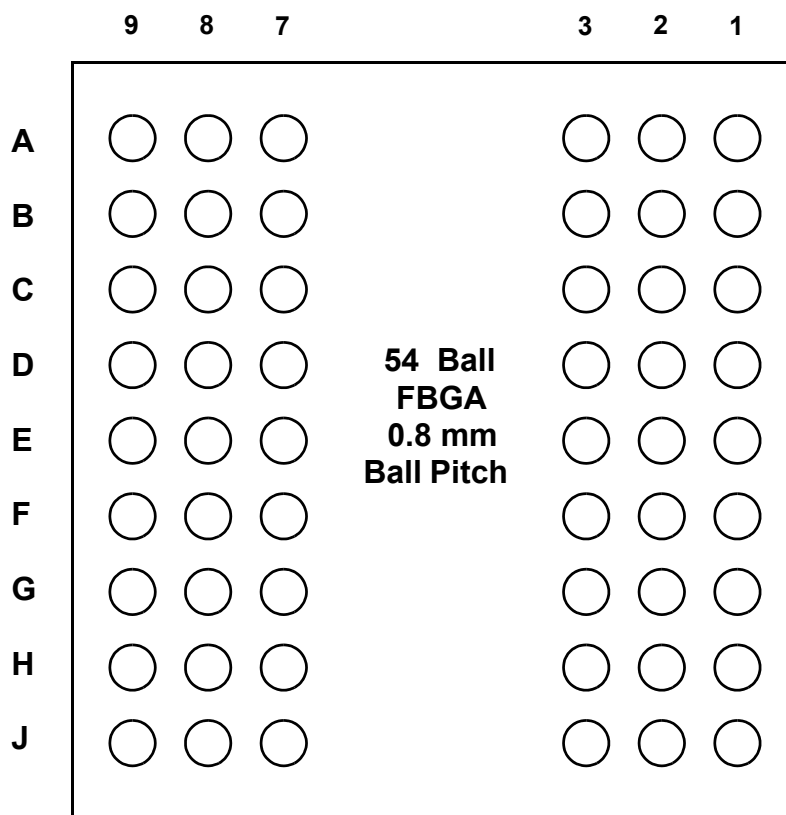
ORDERING INFORMATION

Part No.	Clock Frequency	Power	Organization	Interface	Package
HY5V56BF-HI	133MHz	Normal	4Banks x 4Mbits x16	LVTTL	54ball FBGA
HY5V56BF-8I	125MHz				
HY5V56BF-PI	100MHz				
HY5V56BF-SI	100MHz				
HY5V56B(L)F-HI	133MHz	Low power			
HY5V56B(L)F-8I	125MHz				
HY5V56B(L)F-PI	100MHz				
HY5V56B(L)F-SI	100MHz				

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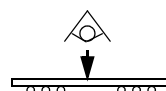
BALL CONFIGURATION



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1	2	3		7	8	9
VSS	DQ15	VSSQ	A	VDDQ	DQ0	VDD
DQ14	DQ13	VDDQ	B	VSSQ	DQ2	DQ1
DQ12	DQ11	VSSQ	C	VDDQ	DQ4	DQ3
DQ10	DQ9	VDDQ	D	VSSQ	DQ6	DQ5
DQ8	NC	VSS	E	VDD	LDQM	DQ7
UDQM	CLK	CKE	F	/CAS	/RAS	/WE
A12	A11	A9	G	BA0	BA1	/CS
A8	A7	A6	H	A0	A1	A10
VSS	A5	A4	J	A3	A2	VDD

< Top View >

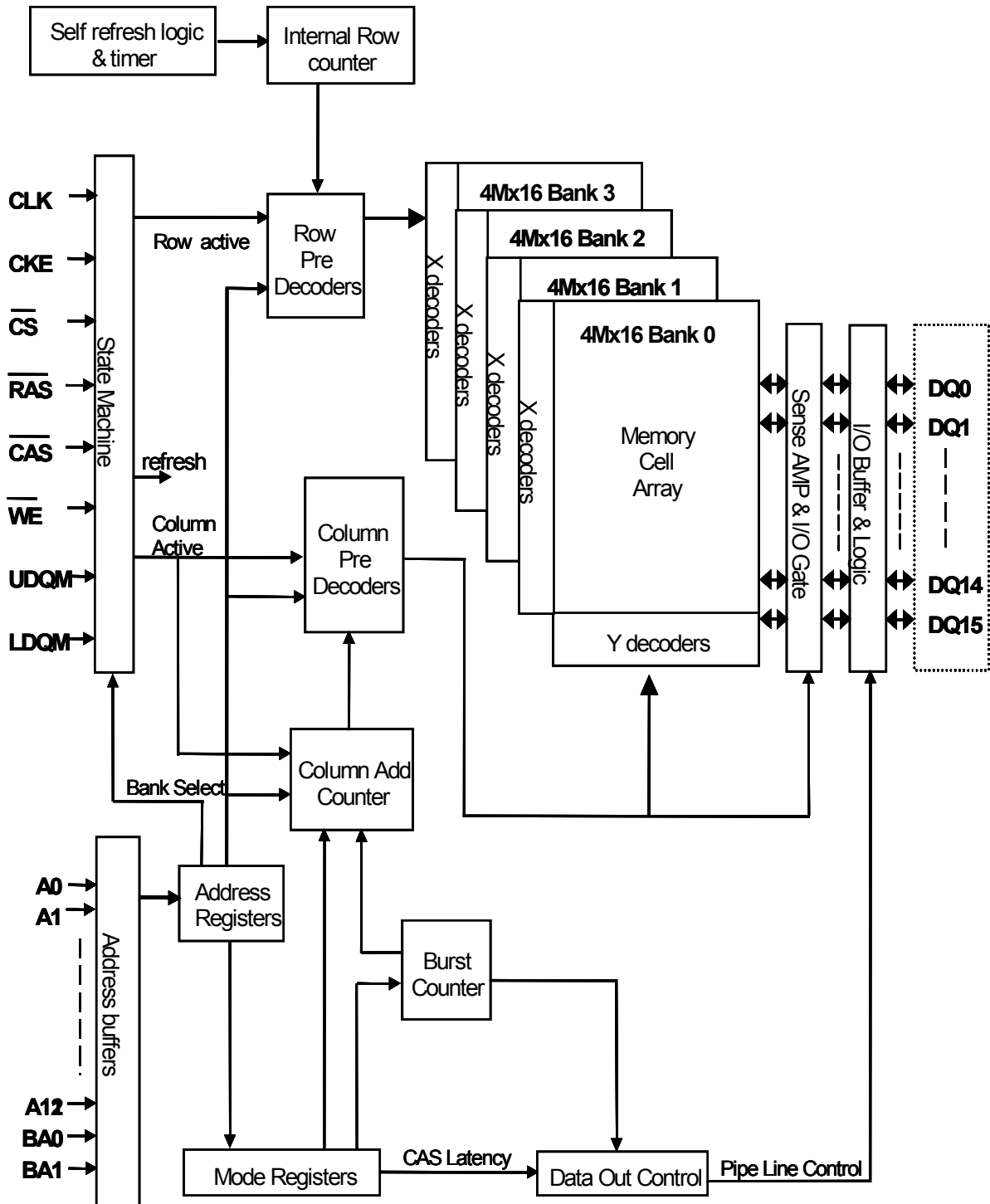


BALL DESCRIPTION

BALL OUT	SYMBOL	TYPE	DESCRIPTION
F2	CLK	INPUT	Clock : The system clock input. All other inputs are registered to the SDRAM on the rising edge of CLK
F3	CKE	INPUT	Clock Enable : Controls internal clock signal and when deactivated, the SDRAM will be one of the states among power down, suspend or self refresh
G9	$\overline{\text{CS}}$	INPUT	Chip Select : Enables or disables all inputs except CLK, CKE, UDQM and LDQM
G7,G8	BA0, BA1	INPUT	Bank Address : Selects bank to be activated during $\overline{\text{RAS}}$ activity Selects bank to be read/written during $\overline{\text{CAS}}$ activity
H7, H8, J8, J7, J3, J2, H3, H2, H1, G3, H9, G2, G1	A0 ~ A12	INPUT	Row Address : RA0 ~ RA12, Column Address : CA0 ~ CA8 Auto-precharge flag : A10
F8, F7, F9	$\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$	INPUT	Command Inputs : $\overline{\text{RAS}}$, $\overline{\text{CAS}}$ and $\overline{\text{WE}}$ define the operation Refer function truth table for details
F1, E8	UDQM, LDQM	INPUT	Data Mask:Controls output buffers in read mode and masks input data in write mode
A8, B9, B8, C9, C8, D9, D8, E9, E1, D2, D1, C2, C1, B2, B1, A2	DQ0 ~ DQ15	I/O	Data Input/Output:Multiplexed data input/output ball
A9, E7, J9, A1, E3, J1	VDD/VSS	SUPPLY	Power supply for internal circuits
A7, B3, C7, D3, A3, B7, C3, D7	VDDQ/ VSSQ	SUPPLY	Power supply for output buffers
E2, G1	NC	-	No connection

FUNCTIONAL BLOCK DIAGRAM

4Mbit x 4banks x 16 I/O Synchronous DRAM



ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rating	Unit
Ambient Temperature	TA	-40 ~ 85	°C
Storage Temperature	TSTG	-55 ~ 125	°C
Voltage on Any ball relative to VSS	VIN, VOUT	-1.0 ~ 4.6	V
Voltage on VDD relative to VSS	VDD, VDDQ	-1.0 ~ 4.6	V
Short Circuit Output Current	IOS	50	mA
Power Dissipation	PD	1	W
Soldering Temperature · Time	TSOLDER	260 · 10	°C · Sec

Note : Operation at above absolute maximum rating can adversely affect device reliability.

DC OPERATING CONDITION (TA=-40 to 85°C)

Parameter	Symbol	Min	Typ	Max	Unit	Note
Power Supply Voltage	VDD, VDDQ	3.0	3.3	3.6	V	1
Input High voltage	VIH	2.0	3.0	VDDQ + 0.3	V	1,2
Input Low voltage	VIL	-0.3	0	0.8	V	1,3

Note :

- 1.All voltages are referenced to VSS = 0V
- 2.VIH(max) is acceptable 5.6V AC pulse width with <=3ns of duration.
- 3.VIL(min) is acceptable -2.0V AC pulse width with <=3ns of duration.

AC OPERATING TEST CONDITION (TA=-40 to 85°C, VDD=3.3±0.3V, VSS=0V)

Parameter	Symbol	Value	Unit	Note
AC Input High / Low Level Voltage	VIH / VIL	2.4/0.4	V	
Input Timing Measurement Reference Level Voltage	Vtrip	1.4	V	
Input Rise / Fall Time	tR / tF	1	ns	
Output Timing Measurement Reference Level Voltage	Voutref	1.4	V	
Output Load Capacitance for Access Time Measurement	CL	50	pF	1

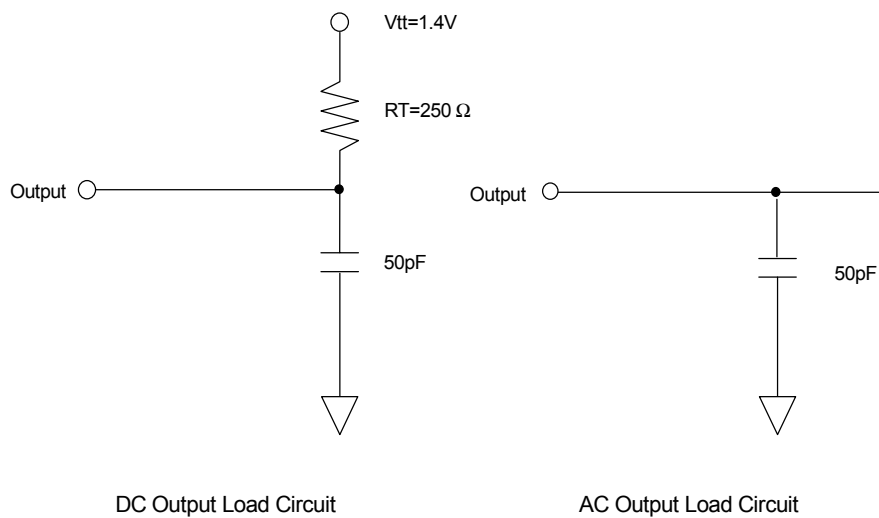
Note :

- 1.Output load to measure access times is equivalent to two TTL gates and one capacitor (50pF). For details, refer to AC/DC output load circuit

CAPACITANCE (TA=25°C, f=1MHz)

Parameter	ball	Symbol	-H		-8/P/S		Unit
			Min	Max	Min	Max	
Input capacitance	CLK	Cl1	2.5	3.5	2.5	4.0	pF
	A0 ~ A12, BA0, BA1, CKE, $\overline{\text{CS}}$, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, WE, UDQM, LDQM	Cl2	2.5	3.8	2.5	5.0	pF
Data input / output capacitance	DQ0 ~ DQ15	Cl/O	4.0	6.5	4.0	6.5	pF

OUTPUT LOAD CIRCUIT



DC CHARACTERISTICS I (TA=-40 to 85°C, VDD=3.3±0.3V)

Parameter	Symbol	Min.	Max	Unit	Note
Input Leakage Current	ILI	-1	1	uA	1
Output Leakage Current	ILO	-1	1	uA	2
Output High Voltage	VOH	2.4	-	V	IOH = -2mA
Output Low Voltage	VOL	-	0.4	V	IOL = +2mA

Note :

- VIN = 0 to 3.6V, All other balls are not tested under VIN =0V
- DOUT is disabled, VOUT=0 to 3.6

DC CHARACTERISTICS II (TA=-45 to 85°C, VDD=3.3±0.3V, VSS=0V)

Parameter	Symbol	Test Condition						Unit	Note
				-HI	-8I	-PI	-SI		
Operating Current	IDD1	Burst length=1, One bank active tRC ≥ tRC(min), IOL=0mA		120	120	110	110	mA	1
Precharge Standby Current in Power Down Mode	IDD2P	CKE ≤ VIL(max), tCK = 15ns		2				mA	
	IDD2PS	CKE ≤ VIL(max), tCK = ∞		1					
Precharge Standby Current in Non Power Down Mode	IDD2N	CKE ≥ VIH(min), $\overline{CS} \geq VIH(min)$, tCK = 15ns Input signals are changed one time during 30ns. All other balls ≥ VDD-0.2V or ≤ 0.2V		15				mA	
	IDD2NS	CKE ≥ VIH(min), tCK = ∞ Input signals are stable.		15					
Active Standby Current in Power Down Mode	IDD3P	CKE ≤ VIL(max), tCK = 15ns		5				mA	
	IDD3PS	CKE ≤ VIL(max), tCK = ∞		5					
Active Standby Current in Non Power Down Mode	IDD3N	CKE ≥ VIH(min), $\overline{CS} \geq VIH(min)$, tCK = 15ns Input signals are changed one time during 30ns. All other balls ≥ VDD-0.2V or ≤ 0.2V		30				mA	
	IDD3NS	CKE ≥ VIH(min), tCK = ∞ Input signals are stable.		20					
Burst Mode Operating Current	IDD4	tCK ≥ tCK(min), IOL=0mA All banks active	CL=3	130	130	110	110	mA	1
			CL=2	140	140	120	120		
Auto Refresh Current	IDD5	tRRC ≥ tRRC(min), All banks active		220	200	200	200	mA	2
Self Refresh Current	IDD6	CKE ≤ 0.2V	Normal	3				mA	3
			Low Power	1.5				mA	4
			SL Power	900				uA	5

Note :

- 1.IDD1 and IDD4 depend on output loading and cycle rates. Specified values are measured with the output open
- 2.Min. of tRRC (Refresh RAS cycle time) is shown at AC CHARACTERISTICS II
- 3.HY5V56BF-HI/8I/PI/SI
- 4.HY5V56BLF-HI/8I/PI/SI
- 5.HY5V56BSF-HI/8I/PI/SI

AC CHARACTERISTICS I (AC operating conditions unless otherwise noted)

Parameter		Symbol	-HI		-8I		-PI		-SI		Unit	Note
			Min	Max	Min	Max	Min	Max	Min	Max		
System Clock Cycle Time	$\overline{\text{CAS}}$ Latency = 3	tCK3	7.5	1000	8	1000	10	1000	10	1000	ns	
	$\overline{\text{CAS}}$ Latency = 2	tCK2	10		10		10		12		ns	
Clock High Pulse Width		tCHW	2.5	-	3	-	3	-	3	-	ns	1
Clock Low Pulse Width		tCLW	2.5	-	3	-	3	-	3	-	ns	1
Access Time From Clock	$\overline{\text{CAS}}$ Latency = 3	tAC3	-	5.4	-	6	-	6	-	6	ns	2
	$\overline{\text{CAS}}$ Latency = 2	tAC2	-	6	-	6	-	6	-	6	ns	
Data-Out Hold Time		tOH	2.5	-	2.5	-	2.5	-	2.5	-	ns	
Data-Input Setup Time		tDS	2	-	2	-	2	-	2	-	ns	1
Data-Input Hold Time		tDH	0.8	-	1	-	1	-	1	-	ns	1
Address Setup Time		tAS	1.5	-	2	-	2	-	2	-	ns	1
Address Hold Time		tAH	0.8	-	1	-	1	-	1	-	ns	1
CKE Setup Time		tCKS	1.5	-	2	-	2	-	2	-	ns	1
CKE Hold Time		tCKH	0.8	-	1	-	1	-	1	-	ns	1
Command Setup Time		tCS	1.5	-	2	-	2	-	2	-	ns	1
Command Hold Time		tCH	0.8	-	1	-	1	-	1	-	ns	1
CLK to Data Output in Low-Z Time		tOLZ	1	-	1	-	1	-	1	-	ns	
CLK to Data Output in High-Z Time	$\overline{\text{CAS}}$ Latency = 3	tOHZ3	2.0	5.4	2.0	6	2.0	6	2.0	6	ns	
	$\overline{\text{CAS}}$ Latency = 2	tOHZ2	2.0	6	2.0	6	2.0	6	2.0	6	ns	

Note :

- Assume t_R / t_F (input rise and fall time) is 1ns
If t_R & $t_F > 1\text{ns}$, then $[(t_R+t_F)/2-1]\text{ns}$ should be added to the parameter
- Access times to be measured with input signals of 1v/ns edge rate, from 0.8v to 2.0v
If $t_R > 1\text{ns}$, then $(t_R/2-0.5)\text{ns}$ should be added to the parameter

AC CHARACTERISTICS II

Parameter		Symbol	-HI		-8I		-PI		-SI		Unit	Note
			Min	Max	Min	Max	Min	Max	Min	Max		
$\overline{\text{RAS}}$ Cycle Time	Operation	tRC	65	-	68	-	70	-	70	-	ns	
	Auto Refresh	tRRC	65	-	68	-	70	-	70	-	ns	
$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Delay		tRCD	20	-	20	-	20	-	20	-	ns	
$\overline{\text{RAS}}$ Active Time		tRAS	45	100K	48	100K	50	100K	50	100K	ns	
$\overline{\text{RAS}}$ Precharge Time		tRP	20	-	20	-	20	-	20	-	ns	
$\overline{\text{RAS}}$ to $\overline{\text{RAS}}$ Bank Active Delay		tRRD	15	-	16	-	20	-	20	-	ns	
$\overline{\text{CAS}}$ to $\overline{\text{CAS}}$ Delay		tCCD	1	-	1	-	1	-	1	-	CLK	
Write Command to Data-In Delay		tWTL	0	-	0	-	0	-	0	-	CLK	
Data-In to Precharge Command		tDPL	2	-	2	-	2	-	2	-	CLK	
Data-In to Active Command		tDAL	5	-	5	-	5	-	5	-	CLK	
DQM to Data-Out Hi-Z		tDQZ	2	-	2	-	2	-	2	-	CLK	
DQM to Data-In Mask		tDQM	0	-	0	-	0	-	0	-	CLK	
MRS to New Command		tMRD	2	-	2	-	2	-	2	-	CLK	
Precharge to Data Output Hi-Z	$\overline{\text{CAS}}$ Latency = 3	tPROZ3	3	-	3	-	3	-	3	-	CLK	
	$\overline{\text{CAS}}$ Latency = 2	tPROZ2	2	-	2	-	2	-	2	-	CLK	
Power Down Exit Time		tPDE	1	-	1	-	1	-	1	-	CLK	
Self Refresh Exit Time		tSRE	1	-	1	-	1	-	1	-	CLK	1
Refresh Time		tREF	-	64	-	64	-	64	-	64	ms	

Note :

1. A new command can be given tRRC after self refresh exit

DEVICE OPERATING OPTION TABLE
HY5V56B(L)F-HI

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
133MHz(7.5ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	5.4ns	2.0ns
125MHz(8ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	6ns	2.0ns
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	2.0ns

HY5V56B(L)F-8I

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
125MHz(8ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	6ns	2.0ns
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	2.0ns
83MHz(12ns)	2CLKs	2CLKs	4CLKs	6CLKs	2CLKs	6ns	2.0ns

HY5V56B(L)F-PI

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	2.0ns
83MHz(12ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	2.0ns
66MHz(15ns)	2CLKs	2CLKs	4CLKs	6CLKs	2CLKs	6ns	2.0ns

HY5V56B(L)F-SI

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
100MHz(10ns)	3CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	2.0ns
83MHz(12ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	2.0ns
66MHz(15ns)	2CLKs	2CLKs	4CLKs	6CLKs	2CLKs	6ns	2.0ns

COMMAND TRUTH TABLE

Command		CKEn-1	CKEn	$\overline{\text{CS}}$	$\overline{\text{RAS}}$	$\overline{\text{CAS}}$	$\overline{\text{WE}}$	DQM	ADDR	A10/ AP	BA	Note
Mode Register Set		H	X	L	L	L	L	X	OP code			
No Operation		H	X	H	X	X	X	X	X			
				L	H	H	H					
Bank Active		H	X	L	L	H	H	X	RA		V	
Read		H	X	L	H	L	H	X	CA	L	V	
Read with Autoprecharge										H		
Write		H	X	L	H	L	L	X	CA	L	V	
Write with Autoprecharge										H		
Precharge All Banks		H	X	L	L	H	L	X	X	H	X	
Precharge selected Bank										L	V	
Burst Stop		H	X	L	H	H	L	X	X			
DQM		H	X					V	X			
Auto Refresh		H	H	L	L	L	H	X	X			
Burst-Read-Single-WRITE		H	X	L	L	L	L	X	A9 ball High (Other balls OP code)			MRS Mode
Self Refresh ¹	Entry	H	L	L	L	L	H	X	X			
	Exit	L	H	H	X	X	X	X				
L				H	H	H						
Precharge power down	Entry	H	L	H	X	X	X	X	X			
				L	H	H	H					
	Exit	L	H	H	X	X	X	X				
				L	H	H	H					
Clock Suspend	Entry	H	L	H	X	X	X	X	X			
				L	V	V	V					
	Exit	L	H	X				X				

Note :

1. Exiting Self Refresh occurs by asynchronously bringing CKE from low to high
2. X = Don't care, H = Logic High, L = Logic Low. BA = Bank Address, RA = Row Address, CA = Column Address, Opcode = Operand Code, NOP = No Operation
3. The burst read single write mode is entered by programming the write burst mode bit (A9) in the mode register to a logic 1.

PACKAGE INFORMATION

54 Ball 0.8mm pitch 8.0mm x 13.5mm FBGA

